

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/041,005	HALASZ ET AL.
	Examiner Shin-Hon Chen	Art Unit 2131

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
726	2-4, 12	9/11/2007	S.C.
726	21	9/11/2007	S.C.
713	154,155	9/11/2007	S.C.
713/168; 709/219,223,225,229; 379/88.17; 455/411,414.1		9/11/2007	S.C.